SC418

EcoSpeed™ DC-DC Buck Controller with Programmable LDO

POWER MANAGEMENT

Features

- Power system
  - Input voltage — 3V to 28V
  - Integrated bootstrap switch
  - Programmable LDO output — 200mA
  - 1% reference tolerance -40 to +85 °C
  - Selectable internal/external bias power supply
  - EcoSpeed™ architecture with pseudo-fixed frequency adaptive on-time control
- Logic input/output control
  - Independent control EN for LDO and switcher
  - Programmable V_{IN} UVLO threshold
  - Power good output
  - Selectable power save mode
  - Programmable ultrasonic power save mode
- Protections
  - Over-voltage/under-voltage
  - TC compensated $R_{DS(ON)}$ sensed current limit
  - Thermal shutdown
  - Smart power save
- Output capacitor types
  - High ESR — SP, POSCAP, OSCON
  - Ceramic capacitors
- Package — 3 x 3mm, 20-pin MLPQ
- Lead-free and halogen free
- RoHS and WEEE compliant

Applications

- Office automation and computing
- Networking and telecommunication equipment
- Point-of-load power supplies and module replacement
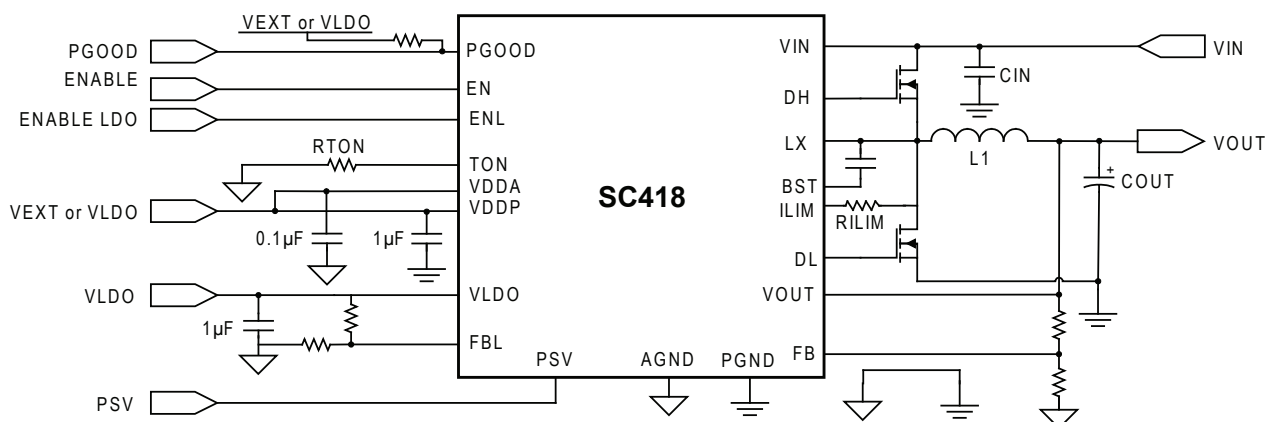
Description

The SC418 is a synchronous EcoSpeed™ buck regulator which incorporates Semtech's advanced, patented adaptive on-time control architecture to provide excellent light-load efficiency and fast transient response. It features an integrated bootstrap switch and programmable LDO in a 3 x 3mm package. The device is highly efficient and uses minimal PCB area.

The SC418 supports using standard capacitor types such as electrolytic or special polymer, in addition to ceramic, at switching frequencies up to 1MHz. The programmable frequency, synchronous operation, and programmable power-save provide high efficiency operation over a wide load range.
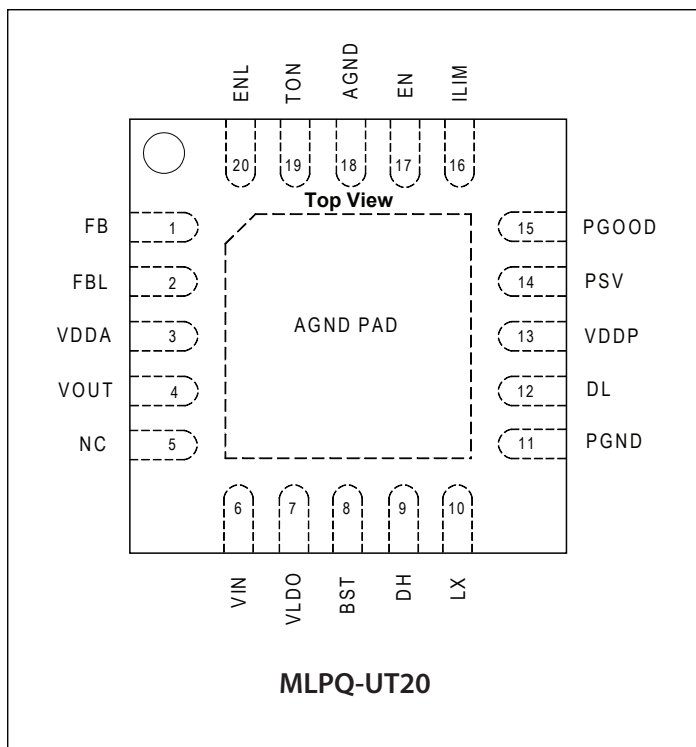
Additional features include cycle-by-cycle current limit, soft-start, under and over-voltage protection, programmable over-current protection, soft shutdown, selectable power-save modes, and programmable ultrasonic power-save. The device also provides separate enable inputs for the PWM controller and LDO as well as a power good output for the PWM controller.

The input voltage can range from 3V to 28V. The wide input voltage range, programmable frequency, and programmable LDO make the device extremely flexible and easy to use in a broad range of applications. Support is provided for single cell or multi-cell battery systems in addition to traditional DC power supply applications.

Typical Application Circuit

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Pin Configuration

MLPQ-UT20

Top View

AGND PAD

Pin	Name
20	ENL
19	TON
18	AGND
17	EN
16	ILIM
1	FB
2	FBL
3	VDDA
4	VOUT
5	NC
6	VIN
7	VLDO
8	BST
9	DH
10	LX
11	PGND
12	DL
13	VDDP
14	PSV
15	PGOOD

Ordering Information

Device	Package
SC418ULTRT[1][2]	MLPQ-UT20
SC418EVB	Evaluation Board

Notes:
1) Available in tape and reel only. A reel contains 3000 devices.
2) Lead-free packaging only. Device is WEEE and RoHS compliant and halogen-free.

Marking Information

418
yyww
xxxx

yyww = Date Code
xxxx = Semtech Lot Number

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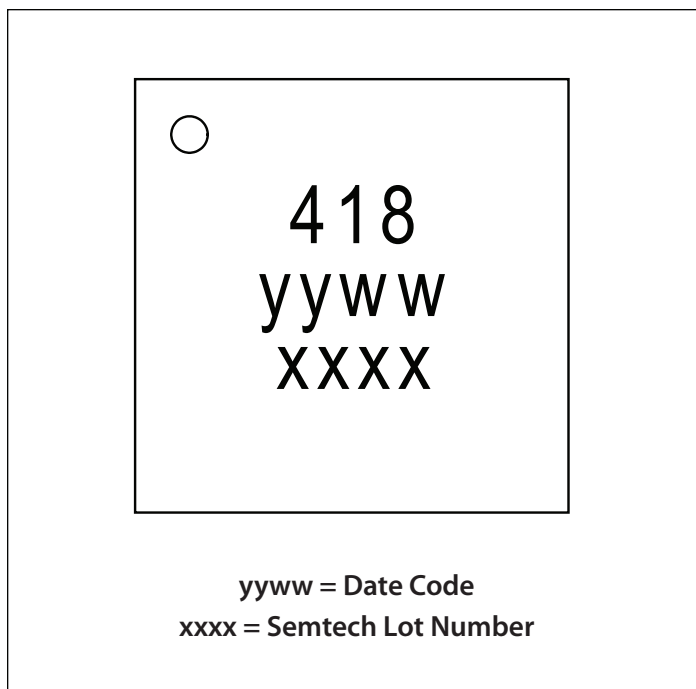
Absolute Maximum Ratings[1]

LX to PGND (V). . . . . -0.3 to +30

LX to PGND (V) (transient — 100ns) . . . . -2 to +30

DH, BST to PGND (V) . . . . -0.3 to +35

DH, BST to LX (V) . . . . -0.3 to +6

DL to PGND (V) . . . . -0.3 to +6

VIN to PGND (V). . . . . -0.3 to +30

EN, FB, FBL, ILIM to AGND (V) . . . . -0.3 to +(VDDA + 0.3)

PGOOD, PSV, TON to AGND (V) . . . . . -0.3 to +(VDDA + 0.3)

VLDO, VOUT to AGND (V) . . . . -0.3 to +(VDDA + 0.3)

TON to AGND (V). . . . . -0.3 to +(VDDA -1.5)

ENL to AGND (V) . . . . -0.3 to VIN

VDDP to PGND, VDDA to AGND (V) . . . . 0.3 to +6

VDDA to VDDP (V) . . . . -0.3 to +0.3

AGND to PGND (V) . . . . -0.3 to +0.3

Recommended Operating Conditions

Input Voltage (V) . . . . 3.0 to 28

VDDA to AGND, VDDP to PGND (V) . . . . 3.0 to 5.5

VOUT to PGND (V) . . . . 0.5 to 5.5

Thermal Information

Storage Temperature (°C). -60 to +150

Maximum Junction Temperature (°C) 150

Operating Junction Temperature (°C) . . . . -40 to +125

Thermal resistance, junction to ambient[2] (°C/W). 50

Peak IR Reflow Temperature (°C) 260

Exceeding the above specifications may result in permanent damage to the device or device malfunction. Operation outside of the parameters specified in the Electrical Characteristics section is not recommended.

NOTES:

(1) This device is ESD sensitive. Use of standard ESD handling precautions is required.

(2) Calculated from package in still air, mounted to 3 x 4.5 (in), 4 layer FR4 PCB with thermal vias under the exposed pad per JESD51 standards.

Electrical Characteristics

Unless specified: V_{IN} =12V, VDDA = VDDP = 5V, T_A = +25°C for Typ, -40 to +85 °C for Min and Max, T_J < 125°C, Typical Application Circuit

Parameter	Conditions	Min	Typ	Max	Units
Input Supplies					
Input Supply Voltage		3		28	V
VIN UVLO Threshold[1]	Sensed at ENL pin, rising edge	2.40	2.60	2.95	V
	Sensed at ENL pin, falling edge	2.235	2.40	2.565	
VIN UVLO Hysteresis	Sensed at ENL pin; EN = 5V		0.2		V
VDDA UVLO Threshold	Measured at VDDA pin, rising edge	2.50	2.90	3.05	V
	Measured at VDDA pin, falling edge	2.40	2.70	2.90	
VDDA UVLO Hysteresis			0.2		V
VIN Supply Current	Shutdown mode; ENL , EN = 0V		8.5	20.0	μA
	Standby mode; VDDA = VDDP = ENL = 5V, EN = 0V, ignore LDO FB resistor bias current		130		

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Electrical Characteristics (continued)

Parameter	Conditions	Min	Typ	Max	Units
Input Supplies (continued)					
VDDA + VDDP Supply Current	ENL , EN = 0V		3	7	µA
	EN = 5V, R_{PSV} = 115kΩ, V_{FB} > 500mV[2]		1.5		mA
	EN = 5V, PSV = open (float), V_{FB} > 500mV[2]		0.4		
	Operating f_{SW} = 250kHz, PSV = VDDA, no load[2]		10		
FB Comparator Threshold	Static VIN and load, 0 to +85 °C	0.496	0.500	0.504	V
	Static VIN and load, -40 to +85 °C	0.495		0.505	V
Frequency Range	Continuous mode operation			1000	kHz
Timing					
On-Time	Forced continuous mode operation, V_{IN} = 15V, V_{OUT} = 5V, R_{TON} = 300kΩ, VDDA = 5V	2385	2650	2915	ns
	VDDA < 4.5V [3]				
Minimum On-Time [2]			80		ns
Minimum Off-Time[2]			250		ns
Ultrasonic Frequency[2]	Minimum switching frequency, R_{PSV} = 115kΩ		25		kHz
Soft-Start					
Soft-Start Ramp Time[2]	V_{OUT} ramp from zero to programmed value		850		µs
Analog Inputs/Outputs					
VOUT Input Resistance			500		kΩ
Current Sense					
Zero Cross Detector Threshold	LX - PGND, VDDA = 5V	-3	0	+3	mV
Power Good					
Power Good Threshold	Upper limit, V_{FB} > internal 500mV reference		+20		%
	Lower limit, V_{FB} < internal 500mV reference		-10		%
Start-Up Delay Time	Includes Soft-Start Ramp Time, VDDA = 5V		2		ms
	Includes Soft-Start Ramp Time, VDDA = 3.3V [2]		1		
Fault (noise immunity) Delay Time[2]			5		µs
Leakage	PGOOD = high impedance (open)			1	µA
Power Good On Resistance			10		Ω

Electrical Characteristics (continued)

Parameter	Conditions	Min	Typ	Max	Units
Fault Protection					
I_{LIM} Source Current		9	10	11	µA
I_{LIM} Source Current Temperature Coefficient [2]			0.41		%/°C
I_{LIM} Comparator Offset	With respect to AGND	-8	0	+8	mV
Output Under-Voltage Threshold	V_{FB} with respect to internal 500mV reference, 8 consecutive cycles		-25		%
Smart Power-Save Protection Threshold[2]	V_{FB} with respect to internal 500mV reference		+10		%
Over-Voltage Protection Threshold	V_{FB} with respect to internal 500mV reference		+20		%
Over-Voltage Fault Delay[2]			5		µs
Over-Temperature Shutdown[2]	10°C hysteresis		150		°C
Logic Inputs/Outputs					
Logic Input High Voltage - EN, ENL [4]		1.0			V
Logic Input High Voltage - PSV	Forced continuous mode operation; PSV with respect to VDDA	-0.4			V
Logic Input Low Voltage - EN, ENL	With respect to AGND			0.4	V
EN Input Bias Current	EN = VDDA or AGND	-10		+10	µA
ENL Input Bias Current	V_{IN} = 28V	-1	11	+18	µA
FB, FBL Input Bias Current	FB, FBL = VDDA or AGND	-1		+1	µA
PSV Input Bias Current	PSV = VDDA		1		µA
Linear Dropout Regulator					
FBL Accuracy	VLDO load = 10mA	0.735	0.75	0.765	V
Current Limit	Start-up and foldback; $V_{LDO} \leq$ 90% of programmed value		115		mA
	Operating	135	200		
VLDO to VOUT Switch-over Threshold [5]		-140		+140	mV
VLDO to VOUT Non-switch-over Threshold [5]		-450		+450	mV
VLDO to VOUT Switch-over Resistance	$V_{LDO} = V_{OUT}$ = 5V		2.0		Ω
	$V_{LDO} = V_{OUT}$ = 3.3V[6]		2.2		
LDO Drop Out Voltage[6]	V_{IN} to V_{VLDO}, V_{VLDO} = 5V, VLDO load = 100mA		1.2		V

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Electrical Characteristics (continued)

Parameter	Conditions	Min	Typ	Max	Units
High-Side Driver (DH, BST, LX)					
Peak Current[2]	VDDP = 5V		2.0		A
On Resistance	$R_{DH\_PULL-UP}$, LX < 0.5V, VDDP = 5V		3.0	6.0	Ω
	$R_{DH\_PULL-UP}$, LX > 0.5V, VDDP = 5V		1.0	2.0	Ω
	$R_{DH\_PULL-DOWN}$, VDDP = 5V		0.6	1.2	Ω
Rise Time[2]	C_{DH-LX} = 3nF, VDDP = 5V		22		ns
Fall Time[2]	C_{DH-LX} = 3nF, VDDP = 5V		12		ns
Propagation Delay[2]	From FB Comparator Input to DH	30	45	60	ns
Shoot-thru Protection Delay[2]		10	20	30	ns
Bootstrap Switch Resistance			10		Ω
Low-Side Driver (DL, VDDP, PGND)					
Peak Current[2]	VDDP = 5V		4.0		A
On Resistance	$R_{DL\_PULL-UP}$, VDDP = 5V		1.3	2.1	Ω
	$R_{DL\_PULL-DOWN}$, VDDP = 5V		0.50	0.86	Ω
Rise Time[2]	C_{DL} = 3nF, VDDP = 5V		7		ns
Fall Time[2]	C_{DL} = 3nF, VDDP = 5V		3.5		ns

Notes:
(1) VIN UVLO is programmable using a resistor divider from VIN to ENL to AGND. The ENL voltage is compared to an internal reference.
(2) Guaranteed by design.
(3) For VDDA less than 4.5V, the On-Time may be limited by the VDDA supply voltage and by V_{IN}. See the TON Limitations and VDDA Supply Voltage section in the Applications Information.
(4) The ENL pin will enable the LDO with 1.0V typical. The ENL pin's VIN ULVO function will disable the switcher unless the ENL pin exceeds the V_{IN} UVLO Threshold (typical 2.5V).
(5) The switch-over threshold is the maximum voltage differential between the VLDO and VOUT pins which ensures that VLDO will internally switch-over to VOUT. The non-switch-over threshold is the minimum voltage differential between the VLDO and VOUT pins which ensures that VLDO will not switch-over to VOUT.
(6) The LDO drop out voltage is the voltage at which the LDO output drops 2% below the nominal regulation point.

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Detailed Application Circuit

Key Components

Component	Value	Manufacturer	Part Number	Web
CIN1, CIN2	10µF/25V	Murata	GRM32DR71E106KA12L	www.murata.com
COUT1, COUT2	220µF/15mΩ/6.3V	Panasonic	EEFUE0J221	www.panasonic.com
L1 (option 1)	0.88µH/2.3mΩ	NEC-Tokin	MPC1040LR88C	www.nec-tokin.com
L1 (option 2)	1.0µH/2.3mΩ	Vishay	IHLP4040DZER1ROM11	www.vishay.com
Q1	IRF7821	I.R.	IRF7821	www.irf.com
Q2	IRF7832	I.R.	IRF7832	www.irf.com

Typical Characteristics

Characteristics in this section are based on using the Detailed Application Circuit.

Efficiency vs. Load — Forced Continuous Mode
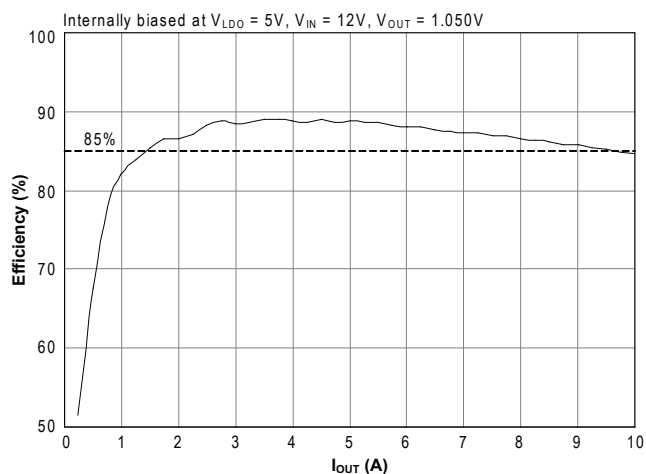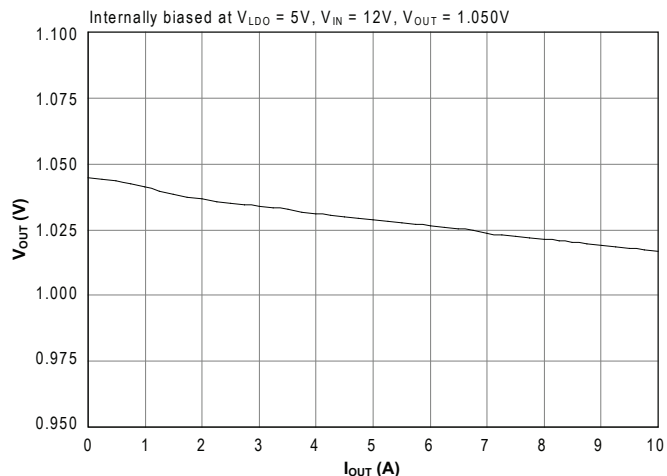
Internally biased at V_{LDO} = 5V, V_{IN} = 12V, V_{OUT} = 1.050V

V_{OUT} vs. Load — Forced Continuous Mode

Internally biased at V_{LDO} = 5V, V_{IN} = 12V, V_{OUT} = 1.050V

Efficiency vs. Load — Ultrasonic Power-save Mode

Internally biased at V_{LDO} = 5V, V_{IN} = 12V, V_{OUT} = 1.050V, R_{PSV} = 115kΩ

V_{OUT} vs. Load — Ultrasonic Power-save Mode

Internally biased at V_{LDO} = 5V, V_{IN} = 12V, V_{OUT} = 1.050V, R_{PSV} = 115kΩ

Efficiency vs. Load — Power-save Mode

Externally biased at VDDA = VDDP = 5V, V_{IN} = 12V, V_{OUT} = 1.050V

V_{OUT} vs. Load — Power-save Mode

Externally biased at VDDA = VDDP = 5V, V_{IN} = 12V, V_{OUT} = 1.050V
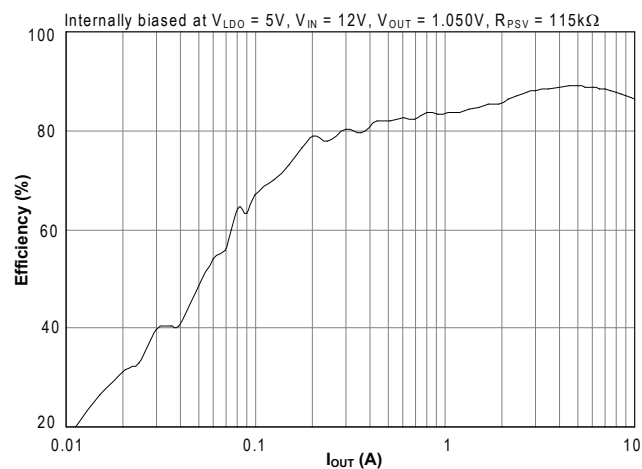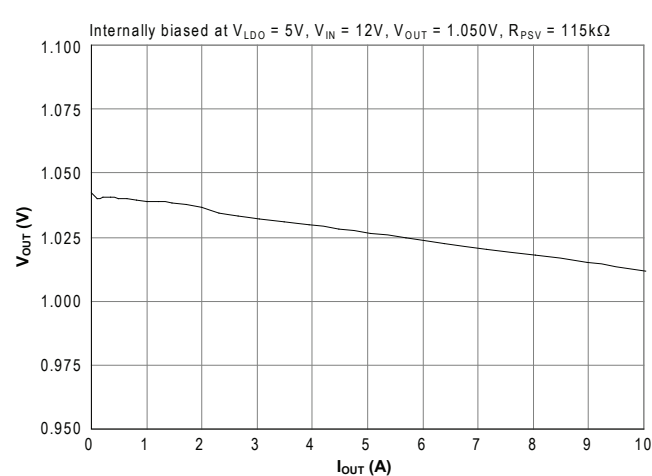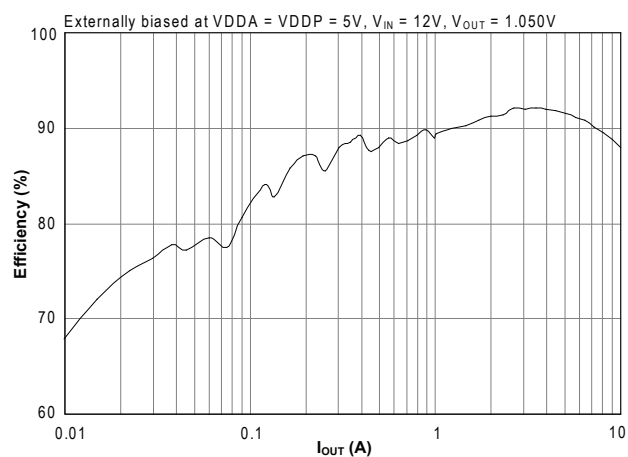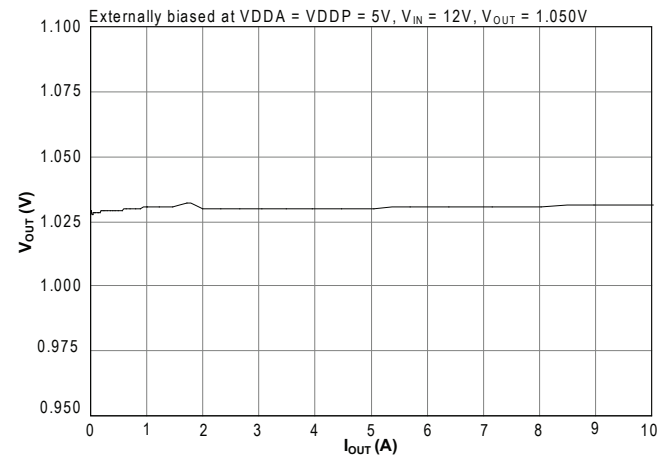
Typical Characteristics (continued)

Characteristics in this section are based on using the Detailed Application Circuit.

Forced Continuous Mode — No Load
Internally biased at V_{LDO} = 5V, V_{IN} = 12V, V_{OUT} = 1.050V, I_{OUT} = 0A

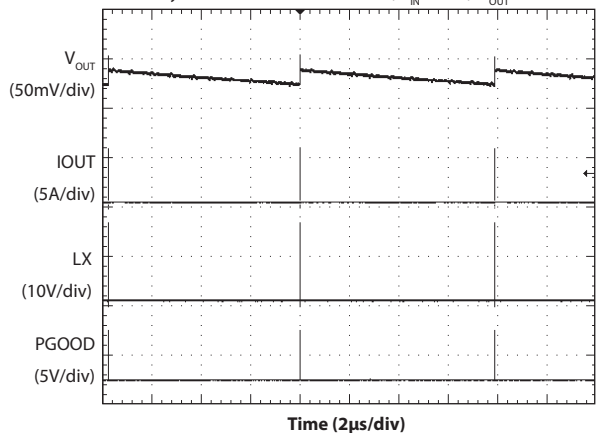V_{OUT} (50mV/div)
LX (10V/div)
DH (10V/div)
DL (5V/div)
Time (2µs/div)
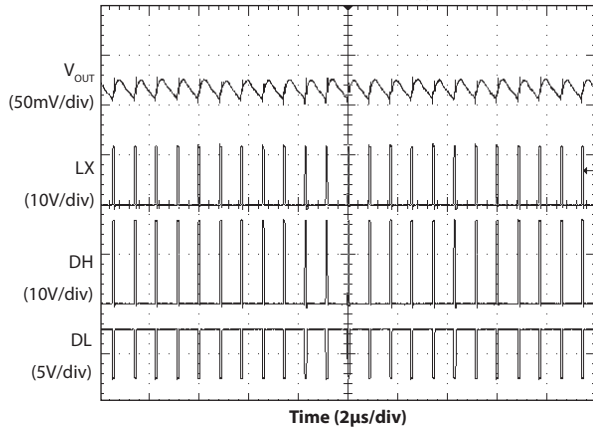
Transient Response — Load Rising
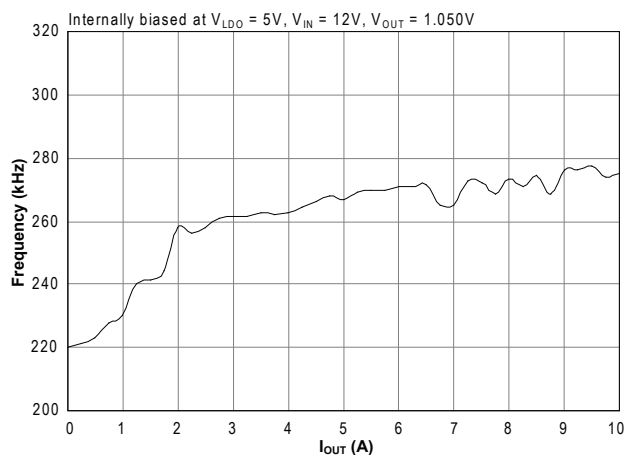Externally biased at VDDA/VDDP = 5V, V_{IN} = 12V, V_{OUT} = 1.050V, I_{OUT} = 0A to 10A

V_{OUT} (50mV/div)
IOUT (5A/div)
LX (10V/div)
PGOOD (5V/div)
Time (40µs/div)
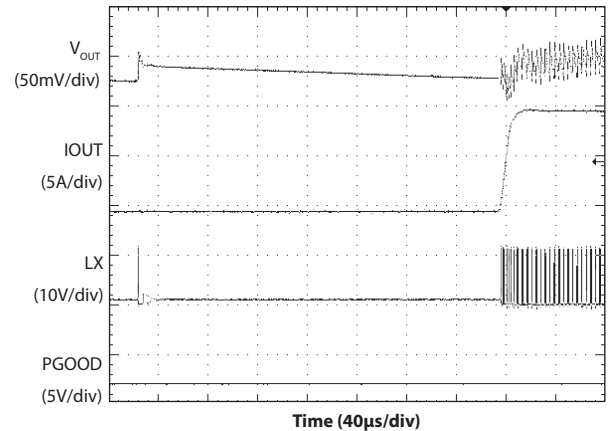
Ultrasonic Powersave Mode — No Load
Internally biased at V_{LDO} = 5V, V_{IN} = 12V, V_{OUT} = 1.050V, R_{PSV} = 115k Ω

V_{OUT} (50mV/div)
LX (10V/div)
DH (10V/div)
DL (5V/div)
Time (5µs/div)
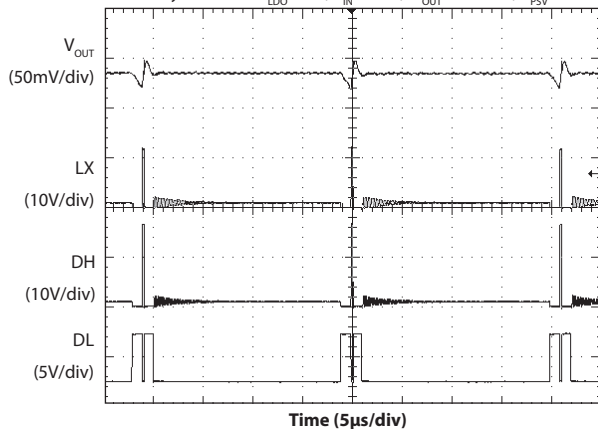
Transient Response — Load Falling
Externally biased at VDDA/VDDP = 5V, V_{IN} = 12V, V_{OUT} = 1.050V, I_{OUT} = 10A to 0A

V_{OUT} (500mV/div)
IOUT (5A/div)
LX (5A/div)
PGOOD (5V/div)
Time (40µs/div)
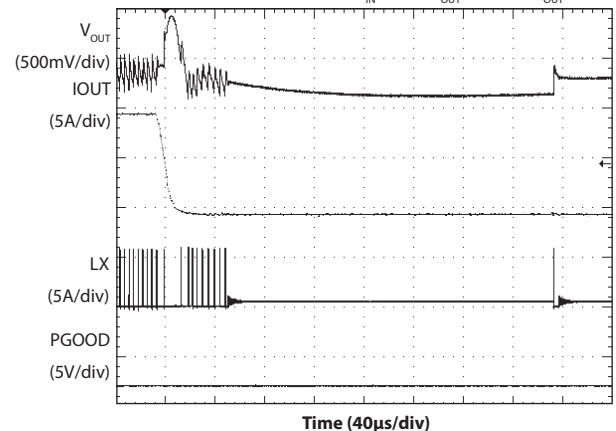
Power-Save Mode — No Load
Externally biased at VDDA/VDDP = 5V, V_{IN} = 12V, V_{OUT} = 1.050V

V_{OUT} (50mV/div)
IOUT (5A/div)
LX (10V/div)
PGOOD (5V/div)
Time (2µs/div)

Enabled Loaded Output — Power Good True
Internally biased at V_{LDO} = 5V, V_{IN} = 12V, V_{OUT} = 1.050V, I_{OUT} = 0A
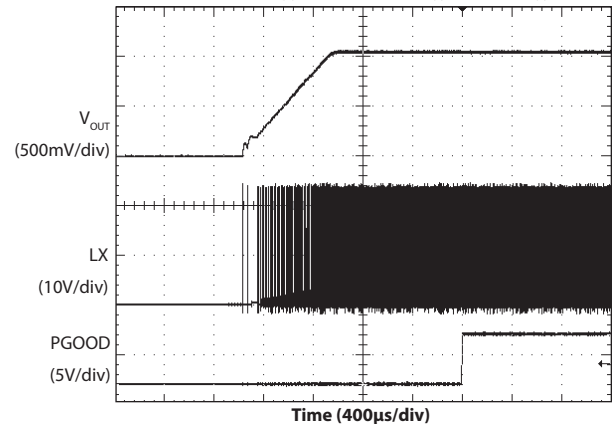
V_{OUT} (500mV/div)
LX (10V/div)
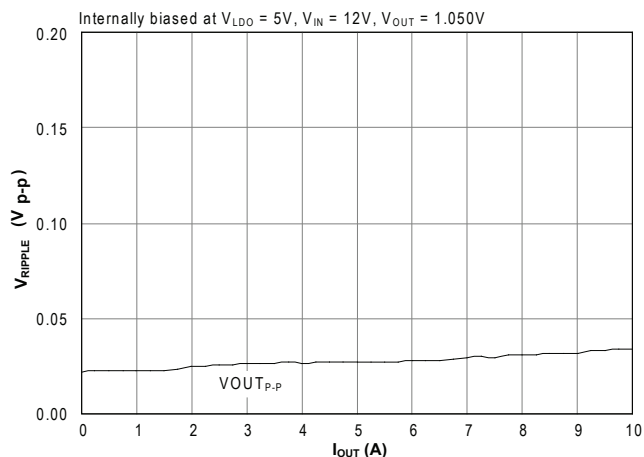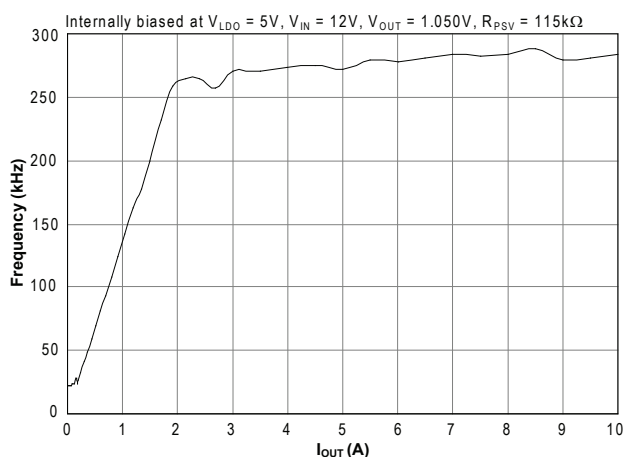PGOOD (5V/div)
Time (400µs/div)

Typical Characteristics (continued)

Characteristics in this section are based on using the Detailed Application Circuit.
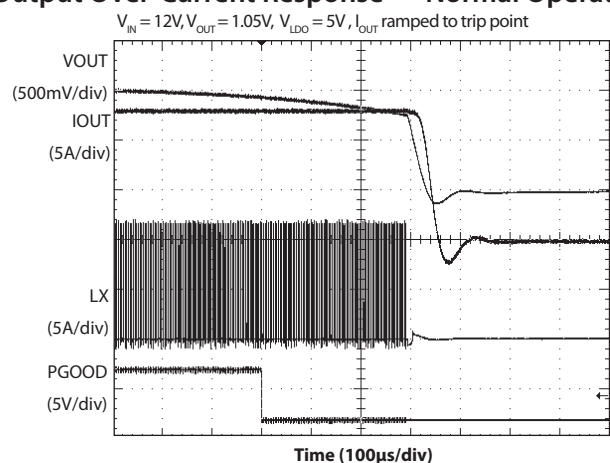
Frequency vs. Load — Forced Continuous Mode

Internally biased at V_{LDO} = 5V, V_{IN} = 12V, V_{OUT} = 1.050V

V_{RIPPLE} vs. Load — Forced Continuous Mode

Internally biased at V_{LDO} = 5V, V_{IN} = 12V, V_{OUT} = 1.050V

$VOUT_{P-P}$

Frequency vs. Load — Ultrasonic Power-Save Mode

Internally biased at V_{LDO} = 5V, V_{IN} = 12V, V_{OUT} = 1.050V, R_{PSV} = 115kΩ

Output Over-Current Response — Normal Operation

V_{IN} = 12V, V_{OUT} = 1.05V, V_{LDO} = 5V, I_{OUT} ramped to trip point

VOUT
(500mV/div)
IOUT
(5A/div)

LX
(5A/div)

PGOOD
(5V/div)

Time (100µs/div)

Frequency vs. Load — Power-Save Mode

Externally biased at VDDA/VDDP = 5V, V_{IN} = 12V, V_{OUT} = 1.050V

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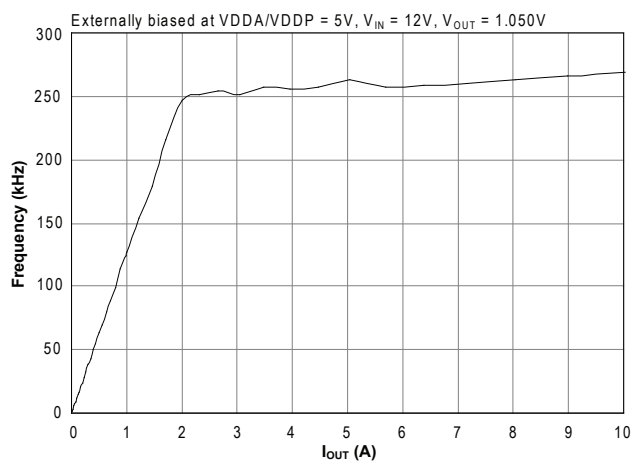
Pin Descriptions

Pin #	Pin Name	Pin Function
1	FB	Feedback input for switching regulator — connect to an external resistor divider from output — used to program the output voltage.
2	FBL	Feedback input for the LDO — connect to an external resistor divider from VLDO to AGND — used to program the LDO output.
3	VDDA	Supply input for internal analog circuits — connect to external 3.3V or 5V supply, or configure the LDO for 3.3V or 5V and connect to VLDO — also the sense input for VDDA UVLO.
4	VOUT	Switcher output voltage sense pin — also the input to the internal switch-over MOSFET between VOUT and VLDO. The voltage at this pin must be less than or equal to the voltage at the VDDA pin.
5	NC	No Connection
6	VIN	Input supply voltage — connect to the same supply used for the high-side MOSFET. Connect a 100nF capacitor from this pin to AGND.
7	VLDO	LDO output — The voltage at this pin must be less than or equal to the voltage at the VDDA pin.
8	BST	Bootstrap pin — connect a 100nF minimum capacitor from BST to LX to develop the floating voltage for the high-side gate drive.
9	DH	High-side gate drive output
10	LX	Switching (phase) node
11	PGND	Power ground
12	DL	Low-side gate drive output
13	VDDP	Supply input for the DH and DL gate drives — connect to the same 3.3V or 5V supply used for VDDA.
14	PSV	Power-save programming input — connect a resistor to AGND to set a minimum (ultrasonic) power-save frequency — float pin to select power-save with no minimum frequency — pull up to VDDA to disable power-save and select forced continuous mode.
15	PGOOD	Open-drain Power Good indicator — high impedance indicates the switching regulator output is good. An external pull-up resistor is required.
16	ILIM	Current limit sense pin — used to program the current limit by connecting a resistor from ILIM to LX.
17	EN	Enable input for switching regulator — logic low disables the switching regulator — logic high enables the switching regulator.
18	AGND	Analog ground
19	TON	ON time programming input — set the on-time by connecting through a resistor to AGND.
20	ENL	Enable input for the LDO and VIN UVLO input for the switching regulator — connect ENL to AGND to disable the LDO — drive to logic high (>3V) to enable the LDO and inhibit VIN UVLO — connect to resistor divider from VIN to AGND to program the V_{IN} UVLO threshold.
PAD	AGND	Analog ground

Block Diagram

A = connected to pins 18 and PAD
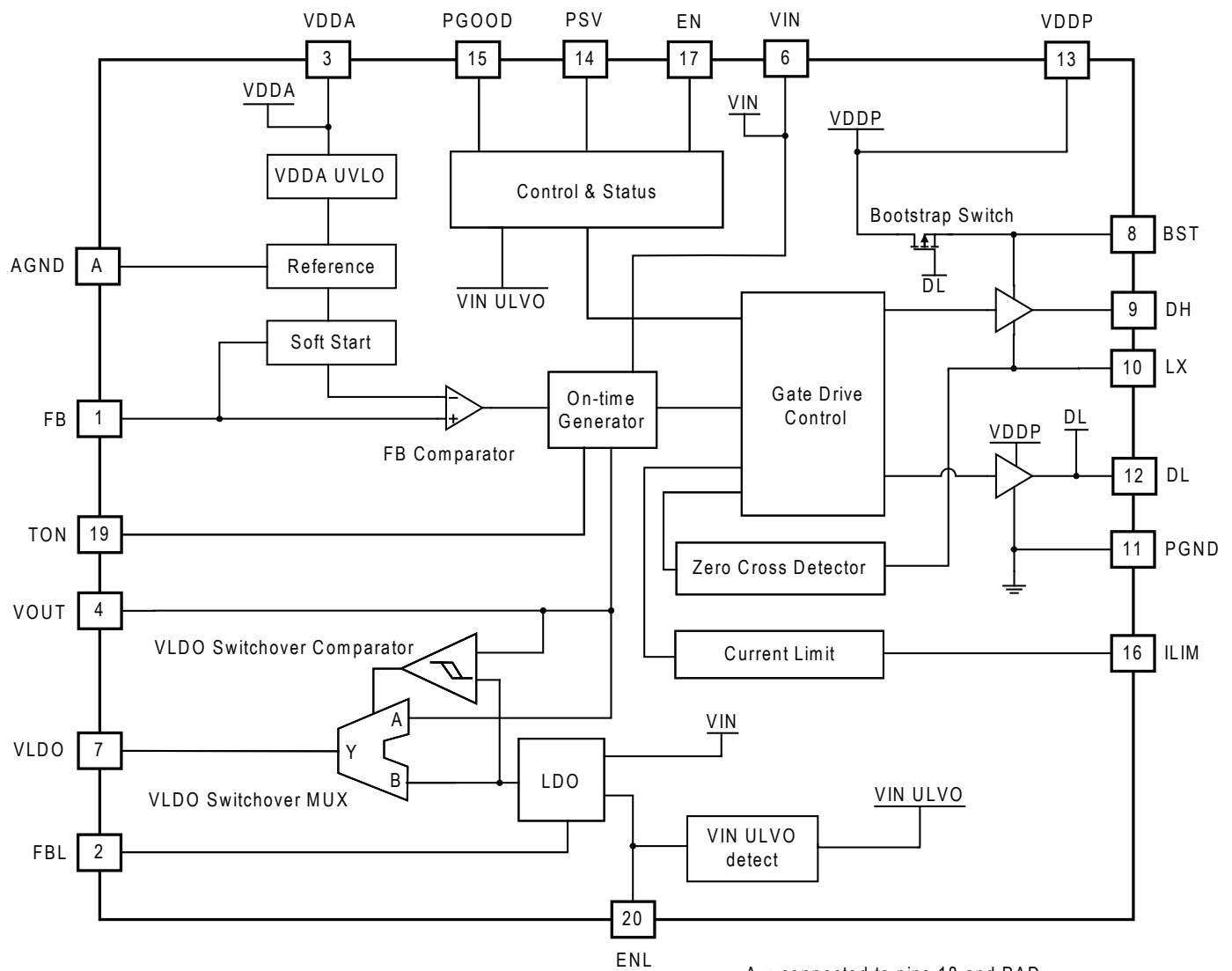
Applications Information

Synchronous Buck Converter
The SC418 is a step down synchronous DC-DC buck con-troller with a programmable LDO. It provides high effi-ciency operation in a space saving 3x3 (mm) 20-pin package. The programmable operating frequency range of 200kHz to 1MHz enables optimizing the configuration for PCB area and efficiency.

The controller uses a pseudo-fixed frequency adaptive on-time control. This allows fast transient response which permits the use of smaller output capacitors.

> In addition to the following information, the user can click on the applicable link to go to the SC418 online C-SIM design and simulation tool, which will lead the user through the design process.

Input Voltage Requirements
The SC418 requires three input supplies for normal opera-tion: V_{IN}, VDDA, and VDDP. V_{IN} operates over the wide range of 3V to 28V. VDDA and VDDP require a 3.3V or 5V supply which can be from an external source or from the internal LDO configured to 3.3V or 5V. VDDA and VDDP should derive from the same source voltage. Power-save operation and Ultrasonic Power-save are not supported for VDDA/VDDP below 4.5V.

Psuedo-fixed Frequency Adaptive On-time Control
The PWM control method used by the SC418 is pseudo-fixed frequency, adaptive on-time, as shown in Figure 1. The ripple voltage generated at the output capacitor ESR is used as a PWM ramp signal. This ripple is used to trigger the on-time of the controller.
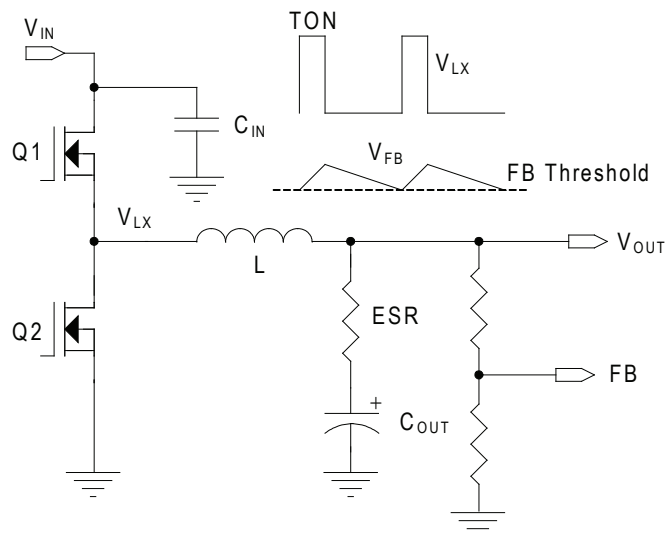

Figure 1 — PWM Control Method, V_{OUT} Ripple

The adaptive on-time is determined by an internal one-shot timer. When the one-shot is triggered by the output ripple, the device sends a single on-time pulse to the high-side MOSFET. The pulse period is determined by V_{OUT} and V_{IN}. The period is proportional to output voltage and inversely proportional to input voltage. With this adaptive on-time configuration, the device automatically antici-pates the on-time needed to regulate V_{OUT} for the present V_{IN} condition and at the selected frequency.

The advantages of adaptive on-time control are:

- Predictable operating frequency compared to other variable frequency methods.
- Reduced component count by eliminating the error amplifier and compensation components.
- Reduced component count by removing the need to sense and control inductor current.
- Fast transient response — the response time is controlled by a fast comparator instead of a typi-cally slow error amplifier.
- Reduced output capacitance due to fast tran-sient response.

One-Shot Timer and Operating Frequency
One-shot timer operation is shown in Figure 2. The FB comparator output goes high when V_{FB} is less than the internal 500mV reference. This feeds into the DH gate drive and turns on the high-side MOSFET, and also starts the one-shot timer. The one-shot timer uses an internal

Applications Information (continued)

comparator and a capacitor. One comparator input is connected to V_{OUT}, the other input is connected to the capacitor. When the on-time begins, the internal capacitor charges from zero volts through a current which is proportional to V_{IN}. When the capacitor voltage reaches V_{OUT}, the on-time is completed and the high-side MOSFET turns off.
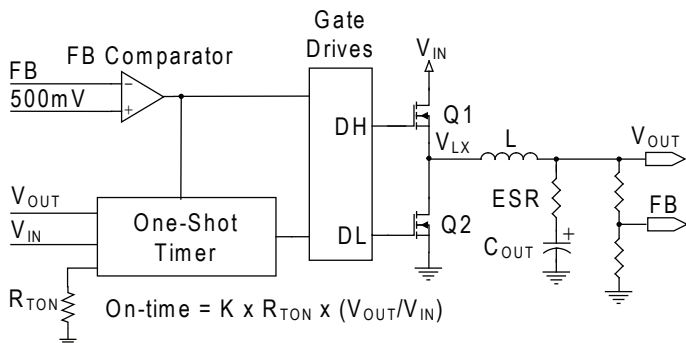

FB Comparator

FB
500mV

Gate Drives

V_{IN}

DH

Q1
V_{LX}
L
V_{OUT}

V_{OUT}
V_{IN}

One-Shot Timer

DL

Q2

ESR

C_{OUT}

FB

R_{TON}

On-time = K x R_{TON} x (V_{OUT}/V_{IN})

Figure 2 — On-Time Generation

This method automatically produces an on-time that is proportional to V_{OUT} and inversely proportional to V_{IN}. Under steady-state conditions, the switching frequency can be determined from the on-time by the following equation.

$$f_{SW} = \frac{V_{OUT}}{T_{ON} \times V_{IN}}$$

The SC418 uses an external resistor to set the on-time which indirectly sets the frequency. The on-time can be programmed to provide an operating frequency from 200kHz to 1MHz using a resistor between the TON pin and ground. The resistor value is selected by the following equation.

$$R_{TON} = \frac{(T_{ON} - 10ns) \times V_{IN}}{25pF \times V_{OUT}}$$

The maximum R_{TON} value allowed is shown by the following equation.

$$R_{TON\_MAX} = \frac{V_{IN\_MIN}}{15\mu A}$$

Immediately after the on-time, the DL output drives high to energize the low-side MOSFET. DL has a minimum high time of ~250ns, after which DL continues to stay high until one of the following occurs:

- VFB falls below the 500mV reference

- The Zero Cross Detector trips if power-save is active

TON Limitations and VDDA Supply Voltage
For VDDA below 4.5V, the TON accuracy may be limited by V_{IN}. The previous RTON equation is accurate if V_{IN} satisfies the below relation over the entire V_{IN} range:

$$V_{IN} < (VDDA - 1.6V) \times 10$$

If V_{IN} exceeds ((VDDA - 1.6V) x 10) for all or part of the V_{IN} range, the previous RTON equation is not accurate. In all cases where VIN > ((VDDA - 1.6V) x 10), the RTON equation must be modified as follows.

$$R_{TON} = \frac{(T_{ON} - 10ns) \times (V5V - 1.6V) \times 10}{25pF \times V_{OUT}}$$

Note that when V_{IN} is greater than ((VDDA - 1.6V) x 10), the actual on-time is fixed and does not vary with V_{IN}. When operating in this condition, the switching frequency will vary inversely with V_{IN} rather than approximating fixed frequency.

When a large capacitor is placed in parallel with R1 (CTOP) VOUT is shown by the following equation.

$$V_{OUT} = 0.5 \times \left(1 + \frac{R_1}{R_2}\right) + \left(\frac{V_{RIPPLE}}{2}\right) \times \sqrt{\frac{1 + (R_1 \omega C_{TOP})^2}{1 + \left(\frac{R_2 \times R_1}{R_2 + R_1} \omega C_{TOP}\right)^2}}$$

The switcher output voltage can be programmed higher than 5V with careful design. In this case the VOUT pin cannot connect directly to the switcher output due to its the maximum voltage rating. An additional resistor divider network is required to connect from the switcher output to the VOUT pin. The voltage at the VOUT pin should be at least 500mV lower than the VDDA supply, to prevent the VLDO switch-over function. For example, the voltage at the VOUT pin can be 4V if VDDA is set for 5V. When the SC418 operates from an external power source and the LDO is disabled by grounding the ENL pin, the voltage at the VOUT pin can be as high as shown in Recommended Operating Conditions. Note that RTON must be adjusted higher by the same divider ratio to

Applications Information (continued)

maintain the desired on-time; on-time is calculated according to the voltage at the VOUT pin.

V_{OUT} Voltage Selection

The switcher output voltage is regulated by comparing V_{OUT} as seen through a resistor divider at the FB pin to the internal 500mV reference voltage (see Figure 3).
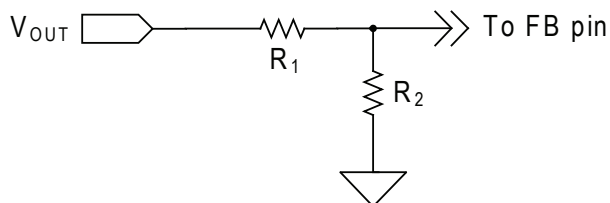

Figure 3 — Output Voltage Selection

Note that this control method regulates the valley of the output ripple voltage, not the DC value. The DC value of V_{OUT} is offset by the output ripple according to the following equation.

$$V_{OUT} = 0.5 \times \left(1 + \frac{R_1}{R_2}\right) + \left(\frac{V_{RIPPLE}}{2}\right)$$

Forced Continuous Mode Operation

The SC418 operates the switcher in Forced Continuous Mode (FCM) by connecting the PSV pin to VDDA. (The PSV pin should never exceed the VDDA supply.) See Figure 4 for FCM waveforms. In this mode one of the power MOSFETs is always on, with no intentional dead time other than to avoid cross-conduction. This results in more uniform frequency across the full load range with the trade-off being reduced efficiency at light loads due to the high-frequency switching of the MOSFETs.
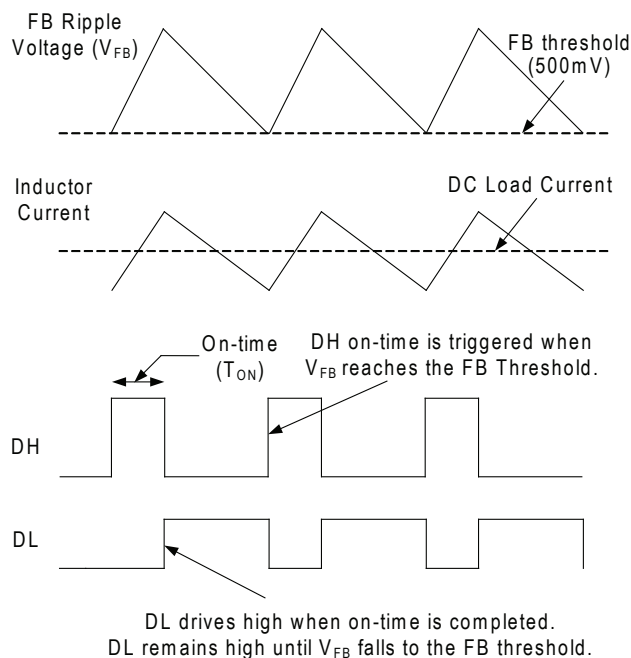
Figure 4 — Forced Continuous Mode Operation

Programmable Ultrasonic Power-Save Operation

The device provides programmable ultrasonic power-save operation at light loads; the minimum operating frequency is programmed by connecting a resistor from PSV to AGND. The SC418 uses the PSV resistor to set an internal timer that monitors the time between consecutive high-side gate pulses. If the time exceeds the programmed timer, DL drives high to turn the low-side MOSFET on. This draws current from V_{OUT} through the inductor, forcing both V_{OUT} and V_{FB} to fall. When V_{FB} drops to the 500mV threshold, the next DH on-time is triggered. After the on-time is completed the high-side MOSFET is turned off and the low-side MOSFET turns on, and the internal timer is restarted. The low-side MOSFET remains on until the inductor current ramps down to zero, at which point the low-side MOSFET is turned off. This ends the cycle until V_{FB} falls below the 500mV threshold, or the internal timer forces another DL turn-on.

Because the period between on-times is limited to a maximum value, a minimum operating frequency is maintained. Figure 5 shows ultrasonic power-save operation.
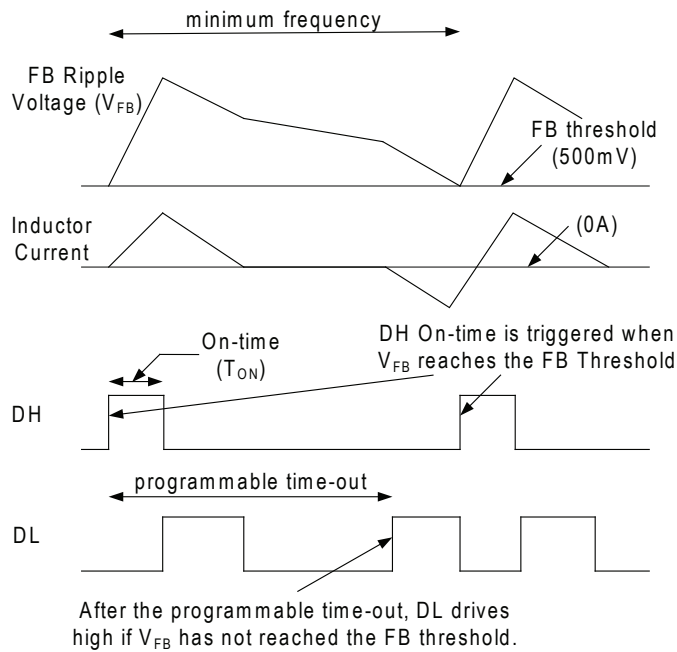
Applications Information (continued)

Figure 5 — Ultrasonic Power-Save Operation

Figure 6 — Power-Save Operation

The equation for determining the R_{PSV} resistor value is shown next. The desired minimum frequency is f_{SWMIN}.

$$R_{PSV} = \frac{1}{350pF \times f_{SWMIN}}$$

Power-Save Mode Operation

The device provides power-save operation at light loads with no minimum operating frequency, selected by float-ing the PSV pin (no connection). In this mode of opera-tion, the zero cross comparator monitors inductor current via the voltage across the low-side MOSFET during the off-time. If the inductor current falls to zero for 8 consecu-tive switching cycles, the controller enters power-save operation. It will then turn off the low-side MOSFET on each subsequent cycle, provided that the current crosses zero. After the low-side MOSFET is off, both high-side and low-sides MOSFETs remain off until V_{FB} drops to the 500mV threshold. While the MOSFETs are off the load is supplied by the output capacitor. If the inductor current does not reach zero on any switching cycle, the controller immedi-ately exits power-save and returns to forced continuous mode. Figure 6 shows power-save operation at light loads.
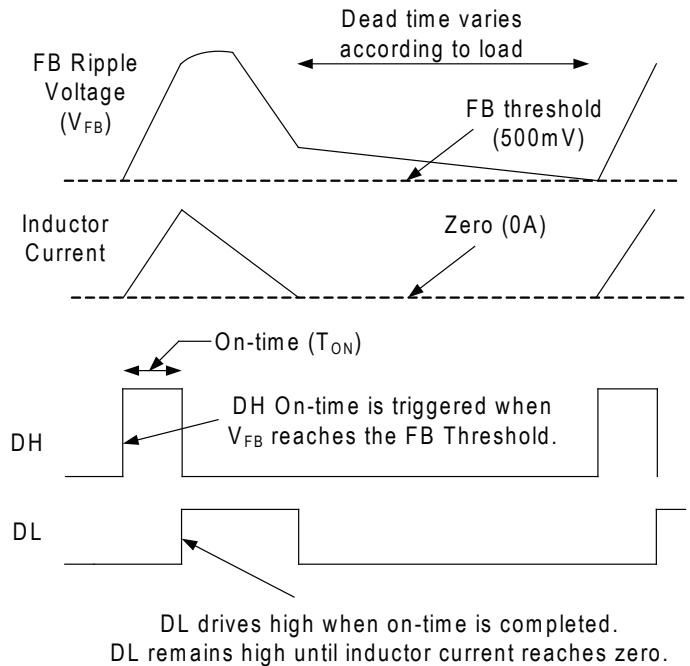
Smart Power-Save Protection

Active loads may leak current from a higher voltage into the switcher output. Under light load conditions with power-save enabled, this can force V_{OUT} to slowly rise and reach the over-voltage threshold, resulting in a hard shut-down. Smart power-save prevents this condition. When the FB voltage exceeds 10% above nominal (exceeds 550mV), the device immediately disables power-save and DL drives high to turn on the low-side MOSFET. This draws current from V_{OUT} through the inductor and causes V_{OUT} to fall. When V_{FB} drops back to the 500mV trip point, a normal T_{ON} switching cycle begins. This method prevents a hard OVP shutdown and cycles energy from V_{OUT} back to V_{IN}. It also minimizes operating power by avoiding forced con-duction mode operation. Figure 7 shows typical wave-forms for the Smart Power-save feature.
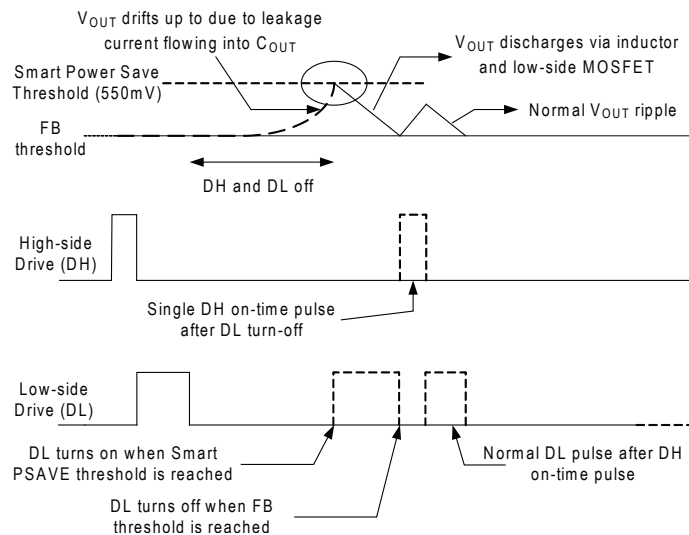
Applications Information (continued)

V$_{OUT}$ drifts up to due to leakage
current flowing into C$_{OUT}$

V$_{OUT}$ discharges via inductor
and low-side MOSFET

Smart Power Save
Threshold (550mV)

Normal V$_{OUT}$ ripple

FB
threshold

DH and DL off

High-side
Drive (DH)

Single DH on-time pulse
after DL turn-off

Low-side
Drive (DL)

DL turns on when Smart
PSAVE threshold is reached

Normal DL pulse after DH
on-time pulse

DL turns off when FB
threshold is reached

Figure 7 — Smart Power-Save

SmartDrive™

For each DH pulse, the DH driver initially turns on the high-side MOSFET at a slower speed, allowing a softer, smooth turn-off of the low-side diode. Once the diode is off and the LX voltage has risen 0.5V above PGND, the SmartDrive circuit automatically drives the high-side MOSFET on at a rapid rate. This technique reduces switching noise while maintaining high efficiency, reducing the need for snubbers or series resistors in the gate drive.

Enable Input for Switching Regulator

The EN input is a logic level input. When EN is low (grounded), the switching regulator is off and in its lowest power state. When EN is low and VDDA is above the VDDA UVLO threshold, the output of the switching regulator soft-discharges into the VOUT pin through an internal 15Ω resistor. When EN is a logic high (≥1V) the switching regulator is enabled.

The EN input has internal resistors — 2MΩ pullup to VDDA, and a 1MΩ pulldown to AGND. These resistors will normally cause the EN voltage to be near the logic high trip point as VDDA reaches the VDDA UVLO threshold. To prevent undesired toggling of EN and erratic startup performance, the EN pin should not be allowed to float as open-circuit.

Note that the LDO enable pin (ENL) can also disable the switching regulator through the V$_{IN}$ UVLO function. Refer to the ENL Pin and V$_{IN}$ UVLO section.

Current Limit Protection

The SC418 features programmable current limiting, which is accomplished using the RDS$_{(ON)}$ of the lower MOSFET for current sensing. The current limit is set by R$_{ILIM}$ resistor which connects from the ILIM pin to the drain of the low-side MOSFET. When the low-side MOSFET is on, an internal 10µA current flows from the ILIM pin and through the R$_{ILIM}$ resistor, creating a voltage drop across the resistor. While the low-side MOSFET is on, the inductor current flows through it and creates a voltage across the RDS$_{(ON)}$. The voltage across the MOSFET is negative with respect to PGND. If this MOSFET voltage drop exceeds the voltage across R$_{ILIM}$, the voltage at the ILIM pin will be negative and current limit will activate. The current limit then keeps the low-side MOSFET on and prevents another high-side on-time, until the current in the low-side MOSFET reduces enough to bring the I$_{LIM}$ voltage up to zero. This method regulates the inductor valley current at the level shown by I$_{LIM}$ in Figure 8.
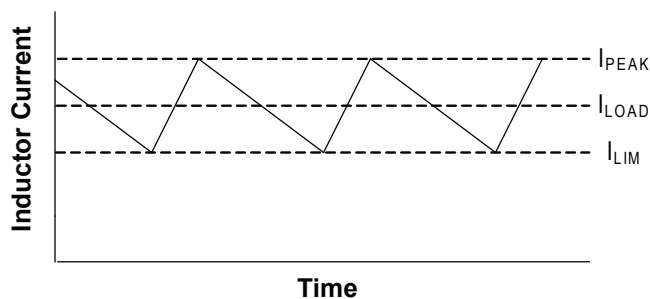
I$_{PEAK}$

I$_{LOAD}$

I$_{LIM}$

Time

Figure 8 — Valley Current Limit

The current limit schematic with the R$_{ILIM}$ resistor is shown in Figure 9.

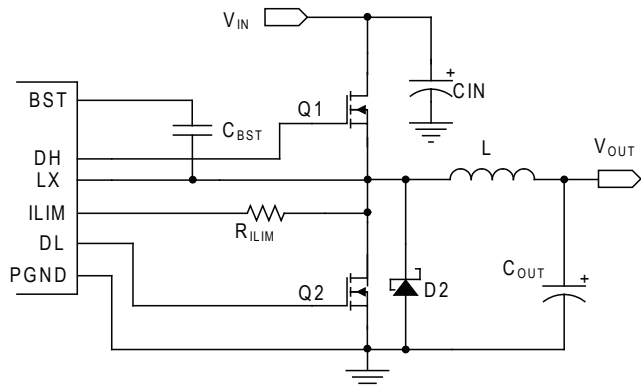## Applications Information (continued)

Figure 9 — Valley Current Limit

Setting the valley current limit to 10A results in a peak inductor current of 10A plus peak ripple current. In this situation the average current through the inductor is 10A plus one-half the peak-to-peak ripple current.

The R_{ILIM} value is calculated by the next equation.

$$R_{ILIM} = \frac{R_{DSON} \times I_{LIM}}{10\mu A}$$

The internal 10μA current source is temperature compensated at 4100ppm in order to provide tracking with the RDS_{ON}.

Note that MOSFET $RDS_{(ON)}$ increases significantly if the VDDP voltage is 3.3V compared to 5.0V. When selecting the R_{ILIM} value, use the $RDS_{(ON)}$ value that corresponds to the VDDP voltage used in the application.

Soft-Start of PWM Regulator

Soft-start is achieved in the PWM regulator by using an internal voltage ramp as the reference for the FB comparator. The voltage ramp is generated using an internal charge pump which drives the reference from zero to 500mV in 1.2mV increments, using an internal 500kHz oscillator. When the ramp voltage reaches 500mV, the ramp is ignored and the FB comparator switches over to a fixed 500mV threshold. During soft-start the output voltage tracks the internal ramp, which limits the start-up inrush current and provides a controlled soft-start profile. Typical soft-start ramp time is 850μs.

During soft-start the regulator turns off the low-side MOSFET on any cycle if the inductor current falls to zero, regardless of the psave setting. This prevents negative inductor current, allowing the device to start into a pre-biased output.

Power Good Output

The PGOOD (power good) output is an open-drain output which requires a pull-up resistor. When the voltage at the FB pin is 10% below the nominal voltage, PGOOD is pulled low. It remains low until the FB voltage returns above -8% of nominal. During start-up PGOOD is held low and will not be allowed to transition high until the PGOOD start-up delay fime has passed and soft-start is completed (when V_{FB} reaches 500mV). The delay time starting from EN going high is typically 2ms for VDDA = 5V and 1ms for VDDA = 3.3V.

PGOOD will transition low if the FB voltage exceeds +20% of nominal (600mV), which is also the over-voltage shut-down threshold. PGOOD also pulls low if the EN pin is low when VDDA is present.

Output Over-Voltage Protection

OVP (Over-voltage protection) becomes active as soon as the device is enabled. The OVP threshold is set at 500mV + 20% (600mV). When V_{FB} exceeds the OVP threshold, DL latches high and the low-side MOSFET is turned on. DL remains high and the controller remains off until the EN input is toggled or VDDA is cycled. There is a 5μs delay built into the OVP detector to prevent false transitions. PGOOD is also low after an OVP event.

Output Under-Voltage Protection

When V_{FB} falls 25% below its nominal voltage (falls to 375mV) for eight consecutive clock cycles, the switcher is shut off and the DH and DL drives are pulled low to tri-state the MOSFETs. The controller stays off until EN is toggled or VDDA is cycled.

VDDA UVLO and POR

The VDDA Under-Voltage Lock-Out (UVLO) circuitry inhibits switching and tri-states the DH/DL drivers until VDDA rises above 2.9V. When VDDA exceeds 2.9V, an internal POR (Power-On Reset) resets the fault latch and the soft-start counter and then the SC418 begins the soft-start

![SEMTECH]

Applications Information (continued)

cycle. The switcher will shut off if VDDA falls below 2.7V. VDDP does not have ULVO protection.

Note that the VDDA UVLO will not stop MOSFET switching until the VDDA voltage falls to 2.7V. During this time the gate driver voltages will track the VDDA supply. Not all MOSFETs will operate or switch effectively at drive levels of 2.7V. For this reason, it is not recommended to rely on VDDA UVLO to shutdown the switcher unless the MOSFETs are capable of operating with 2.7V drive.

LDO Regulator

The LDO output is programmable from 0.75V to 5.25V using external resistors. The feedback pin (FBL) for the LDO is regulated to 750mV. The LDO enable pin (ENL) provides independent control. The LDO voltage can be used to provide the bias voltage for the switching regulator. When a separate source is used as the bias supply, the LDO can be programmed to provide a different voltage. The external resistor connections are shown in Figure 10.
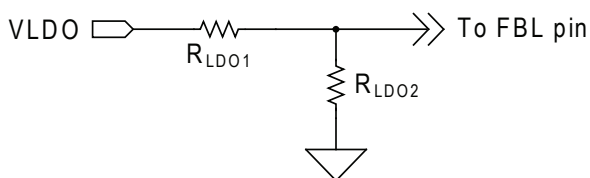
Figure 10 — VLDO Resistor Divider

The LDO output voltage is set by the following equation.

$$VLDO = 750mV \times \left(1 + \frac{R_{LDO1}}{R_{LDO2}}\right)$$

A minimum capacitance of 1µF referenced to AGND is normally required at the output of the LDO for stability. If the LDO is providing bias power to the device, then a minimum 0.1µF capacitor referenced to AGND is required, along with a minimum 1µF capacitor referenced to PGND to filter the gate drive pulses. Refer to the PCB Layout Guidelines section.

ENL Pin and VIN UVLO

The ENL pin also acts as the V_{IN} under-voltage lockout for the switcher. The V_{IN} UVLO voltage is programmable via a resistor divider at the VIN, ENL and AGND pins. The V_{IN} UVLO function has a typical threshold of 2.6V on the V_{IN} rising edge. The falling edge threshold is 2.4V.

Timing is important when driving ENL with logic and not implementing V_{IN} UVLO. The ENL pin must transition from high to low within 2 switching cycles to avoid the PWM output turning off. If ENL goes below the V_{IN} UVLO threshold and stays above 1V, then the switcher will turn off but the LDO will remain on.

Note that it is possible to operate the switcher with the LDO disabled, but the ENL pin must be below the logic low threshold (0.4V maximum), otherwise the V_{IN} UVLO function will disable the switcher.

The table below summarizes the function of the ENL and EN pins, with respect to the rising edge of ENL.

EN	ENL	LDO status	Switcher status
low	low, < 0.4V	off	off
high	low, < 0.4V	off	on
low	high, < 2.6V	on	off
high	high, < 2.6V	on	off
low	high, > 2.6V	on	off
high	high, > 2.6V	on	on

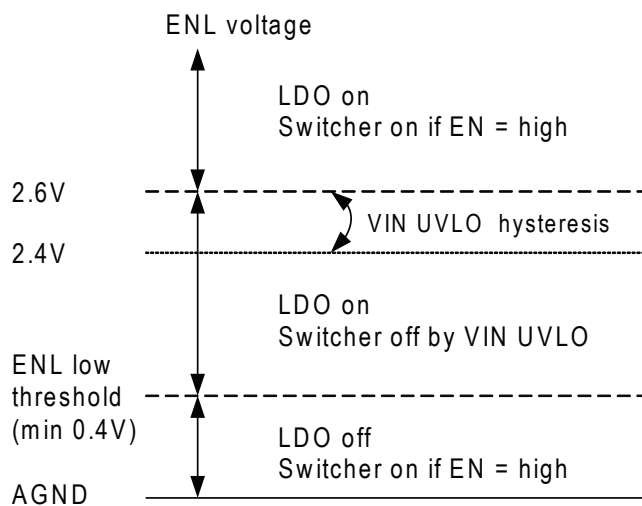Figure 11 shows the ENL voltage thresholds and their effect on LDO and Switcher operation.

Figure 11 — ENL Thresholds

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Applications Information (continued)

ENL Logic Control of PWM Operation

When the ENL input exceeds the VIN UVLO threshold of 2.6V, internal logic checks the PGOOD signal. If PGOOD is high, the switcher is already running and the LDO will start without affecting the switcher. If PGOOD is low, the device disables PWM switching until the LDO output has reached 90% of its final value. This delay prevents the additional current needed by the DH and DL gate drives from over-loading the LDO at start-up.

In some cases it is desirable to use the V_{IN} UVLO feature for the switcher without using the LDO. This can be done by connecting the FBL pin directly to VDDA. This disables the LDO, allowing the ENL pin to be used only for VIN UVLO for the switcher.

LDO Start-up

Before LDO start-up, the device checks the status of the following signals to ensure proper operation can be maintained.

1. ENL pin
2. VLDO output
3. V_{IN} input voltage

When the ENL pin is high and V_{IN} is available, the LDO will begin start-up. During the initial phase, when VLDO is near zero, the LDO initiates a current-limited start-up (typically 115mA) to charge the output capacitor. When V_{LDO} has reached 90% of the final value (as sensed at the FBL pin), the LDO current limit is increased to 200mA and the LDO output is quickly driven to the nominal value. The LDO start-up is shown in Figure 12.
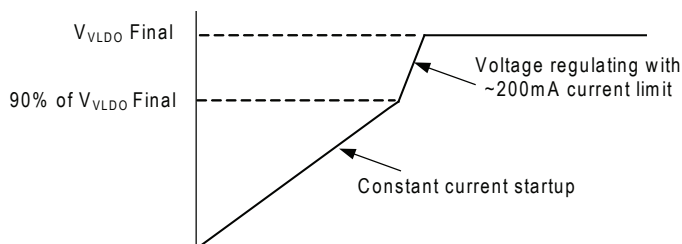

V_{VLDO} Final

90% of V_{VLDO} Final

Voltage regulating with ~200mA current limit

Constant current startup

Figure 12 — LDO Start-Up

LDO Switch-Over Operation

The SC418 includes a switch-over function for the LDO. The switch-over function is designed to increase efficiency by using the more efficient DC-DC converter to power the LDO output, avoiding the less efficient LDO regulator when possible. The switch-over function connects the VLDO pin directly to the VOUT pin through an internal switch. When the switch-over is complete the LDO is turned off, which reduces operating power loss. If the LDO output is used to bias the SC418, then after switch-over the device is self-powered from the switching regulator with the LDO turned off.

After the switcher completes soft-start, the switch-over logic waits for 32 switching cycles before it starts the switch-over. There are two methods of completing the switch-over of V_{LDO} to V_{OUT}.

In the first method, the LDO is already in regulation when the DC-DC converter is enabled. As soon as the PGOOD output goes high, the 32 cycle count is started. The voltages at the VLDO and VOUT pins are then compared; if the two voltages are within ±300mV of each other, the VLDO pin connects to the VOUT pin using an internal switch, and the LDO is turned off.

In the second method, the DC-DC converter is already running and the LDO is enabled. In this case the 32 cycle count is started as soon as the LDO reaches 90% of its final value. At this time, the VLDO and VOUT pins are compared, and if within ±300mV the switch-over occurs and the LDO is turned off.

Switch-over Limitations on VOUT and VLDO

Because the internal switch-over circuit always compares the VOUT and VLDO pins at start-up, there are limitations on permissible combinations of VOUT and VLDO. Consider the case where VOUT is programmed to 1.5V and VLDO is programmed to 1.8V. After start-up, the device would connect VOUT to VLDO and disable the LDO, since the two voltage are within the ±300mV switch-over window. To avoid unwanted switch-over, the minimum difference between VOUT and VLDO should be ±500mV.

![SEMTECH]

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It is not recommended to use the switch-over feature for an output voltage of 3.3V or less since this does not provide sufficient voltage for the gate-source drive to the internal p-channel switch-over MOSFET.

It is not recommended to use the switch-over feature in cases where the device is powered from 3.3V which is initially derived from the LDO. If the switch-over was used, then the 3.3V switcher output would pass through the switch-over MOSFET to power the VDDA/VDDP pins. The $RDS_{(ON)}$ of the switch-over device, typically 2.2 ohms at 3.3V, will cause a voltage drop across the device. The VDDA/VDDP pins would be typically 200mV or more below the 3.3V rail, due to the IR drop caused by the VDDA/VDDP current. If this voltage drop becomes large enough, the VDDA voltage will drop near the VDDA UVLO threshold, causing the device to shutdown.

Switch-over MOSFET Parasitic Diodes
The switch-over MOSFET contains parasitic diodes that are inherent to its construction, as shown in Figure 13.
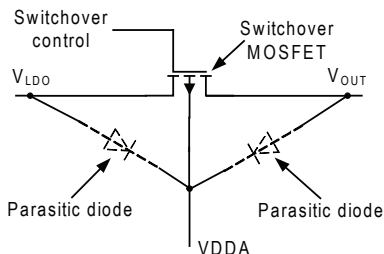
Figure 13— Switch-over MOSFET Parasitic Diodes

It is important to prevent forward bias of these diodes. The following two conditions must be satisfied in order for the parasitic diodes to stay off.

- VDDA $\geq$ V_{LDO}
- VDDA $\geq$ V_{OUT}

If either V_{LDO} or V_{OUT} is higher than VDDA, then the respective diode will turn on and the SC418 operating current will then flow through this diode. This has the potential of damaging the device.

Note that if the VDDA supply is 3.3V then both the LDO and switching regulator outputs are limited to 3.3V maximum. Trying to obtain higher voltages such as 5V

will forward-bias one of the parasitic diodes and could damage the device.

Using the Internal LDO to Bias the SC418
The following steps must be followed when using the internal LDO to bias the device.

- Connect VDDA and VDDP to VLDO before enabling the LDO.
- Any external load on VLDO should not exceed 40mA until the LDO voltage has reached 90% of final value.

When the switch-over feature is used and the VDDA/VDDP power comes from V_{OUT}, the EN and ENL inputs must be used carefully. Do not connect the EN pin directly to VDDA or another supply voltage. If this is done, driving the ENL pin low (to AGND) will turn off the LDO and the LDO switch-over MOSFET, but the switcher will continue operating. V_{OUT} will feed into the LDO output and the VDDA/VDDP supplies through the internal parasitic diode. This can potentially damage the device, and also prevents the switcher from shutting off until the VDDA supply drops below the VDDA UVLO threshold. For these applications a dedicated logic signal is required to drive EN low and disable the switcher. This signal can be combined with the ENL signal if needed.

Design Procedure
When designing a switch mode supply the input voltage range, load current, switching frequency, and inductor ripple current must be specified.

The maximum input voltage (V_{INMAX}) is the highest specified input voltage. The minimum input voltage (V_{INMIN}) is determined by the lowest input voltage after evaluating the voltage drops due to connectors, fuses, switches, and PCB traces.

The following parameters define the design.

- Nominal output voltage (V_{OUT})
- Static or DC output tolerance
- Transient response
- Maximum load current (I_{OUT})

There are two values of load current to evaluate — continuous load current and peak load current. Continuous

Applications Information (continued)

load current relates to thermal stresses which drive the selection of the inductor and input capacitors. Peak load current determines instantaneous component stresses and filtering requirements such as inductor saturation, output capacitors, and design of the current limit circuit.

The following values are used in this design.

- $V_{IN} = 12V \pm 10\%$
- $V_{OUT} = 1.05V \pm 4\%$
- $f_{SW} = 250kHz$
- Load = 10A maximum

Frequency Selection
Selection of the switching frequency requires making a trade-off between the size and cost of the external filter components (inductor and output capacitor) and the power conversion efficiency.

The desired switching frequency is 250kHz.

A resistor, R_{TON} is used to program the on-time (indirectly setting the frequency) using the following equation.

$$R_{TON} = \frac{(T_{ON} - 10ns) \times V_{IN}}{25pF \times V_{OUT}}$$

To select R_{TON}, use the maximum value for V_{IN}, and for T_{ON} use the value associated with maximum V_{IN}.

$$T_{ON} = \frac{V_{OUT}}{V_{INMAX} \times f_{SW}}$$

T_{ON} = 318 ns at $13.2V_{IN}$, $1.05V_{OUT}$, 250kHz

Substituting for R_{TON} results in the following solution.

R_{TON} = 154.9kΩ, use R_{TON} = 154kΩ

Inductor Selection
In order to determine the inductance, the ripple current must first be defined. Low inductor values result in smaller size but create higher ripple current which can reduce efficiency. Higher inductor values will reduce the ripple current/voltage and for a given DC resistance are more efficient. However, larger inductance translates directly into larger packages and higher cost. Cost, size, output ripple, and efficiency are all used in the selection process.

The ripple current will also set the boundary for power-save operation. The switching will typically enter power-save mode when the load current decreases to 1/2 of the ripple current. For example, if ripple current is 4A then Power-save operation will typically start for loads less than 2A. If ripple current is set at 40% of maximum load current, then power-save will start for loads less than 20% of maximum current.

The inductor value is typically selected to provide a ripple current that is between 25% to 50% of the maximum load current. This provides an optimal trade-off between cost, efficiency, and transient performance.

During the DH on-time, voltage across the inductor is $(V_{IN} - V_{OUT})$. The following equation for determining inductance is shown.

$$L = \frac{(V_{IN} - V_{OUT}) \times T_{ON}}{I_{RIPPLE}}$$

In this example the inductor ripple current is set equal to 50% of the maximum load current. Thus ripple current will be 50% x 10A or 5A.

To find the minimum inductance needed, use the V_{IN} and T_{ON} values that correspond to V_{INMAX}.

$$L = \frac{(13.2 - 1.05) \times 318ns}{5A} = 0.77\mu H$$

A slightly larger value of 0.88μH is selected. This will decrease the maximum I_{RIPPLE} to 4.4A.

Note that the inductor must be rated for the maximum DC load current plus 1/2 of the ripple current.

The ripple current under minimum V_{IN} conditions is also checked using the following equations.

$$T_{ON\_VINMIN} = \frac{25pF \times R_{TON} \times V_{OUT}}{V_{INMIN}} + 10ns = 384ns$$

$$I_{RIPPLE} = \frac{(V_{IN} - V_{OUT}) \times T_{ON}}{L}$$

$$I_{RIPPLE\_VINMIN} = \frac{(10.8 - 1.05) \times 384ns}{088\mu H} = 4.25A$$

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Applications Information (continued)

Capacitor Selection

The output capacitors are chosen based on required ESR and capacitance. The maximum ESR requirement is controlled by the output ripple requirement and the DC tolerance. The output voltage has a DC value that is equal to the valley of the output ripple plus 1/2 of the peak-to-peak ripple. Change in the output ripple voltage will lead to a change in DC voltage at the output.

The design goal is for the output voltage regulation to be ±4% under static conditions. The internal 500mV reference tolerance is 1%. Allowing 1% tolerance from the FB resistor divider, this allows 2% tolerance due to V_{OUT} ripple. Since this 2% error comes from 1/2 of the ripple voltage, the allowable ripple is 4%, or 42mV for a 1.05V output.

The maximum ripple current of 4.4A creates a ripple voltage across the ESR. The maximum ESR value allowed is shown by the following equations.

$$ESR_{MAX} = \frac{V_{RIPPLE}}{I_{RIPPLEMAX}} = \frac{42mV}{4.4A}$$

$$ESR_{MAX} = 9.5 \ m\Omega$$

The output capacitance is chosen to meet transient requirements. A worst-case load release, from maximum load to no load at the exact moment when inductor current is at the peak, determines the required capacitance. If the load release is instantaneous (load changes from maximum to zero in < 1µs), the output capacitor must absorb all the inductor's stored energy. This will cause a peak voltage on the capacitor according to the following equation.

$$COUT_{MIN} = \frac{L\left(I_{OUT} + \frac{1}{2} \times I_{RIPPLEMAX}\right)^2}{\left(V_{PEAK}\right)^2 - \left(V_{OUT}\right)^2}$$

Assuming a peak voltage V_{PEAK} of 1.150 (100mV rise upon load release), and a 10A load release, the required capacitance is shown by the next equation.

$$COUT_{MIN} = \frac{0.88\mu H\left(10 + \frac{1}{2} \times 4.4\right)^2}{\left(1.15\right)^2 - \left(1.05\right)^2}$$

$$COUT_{MIN} = 595\mu F$$

If the load release is relatively slow, the output capacitance can be reduced. At heavy loads during normal switching, when the FB pin is above the 500mV reference, the DL output is high and the low-side MOSFET is on. During this time, the voltage across the inductor is approximately $-V_{OUT}$. This causes a down-slope or falling di/dt in the inductor. If the load di/dt is not faster than the -di/dt in the inductor, then the inductor current will tend to track the falling load current. This will reduce the excess inductive energy that must be absorbed by the output capacitor, therefore a smaller capacitance can be used.

The following can be used to calculate the needed capacitance for a given dI_{LOAD}/dt. Peak inductor current is shown by the next equation.

$$I_{LPK} = I_{MAX} + 1/2 \times I_{RIPPLEMAX}$$

$$I_{LPK} = 10 + 1/2 \times 4.4 = 12.2A$$

$$Rate \ of \ change \ of \ Load \ Current = \frac{dI_{LOAD}}{dt}$$

I_{MAX} = maximum load release = 10A

$$C_{OUT} = I_{LPK} \times \frac{L \times \dfrac{I_{LPK}}{V_{OUT}} - \dfrac{I_{MAX}}{dI_{LOAD}} \times dt}{2\left(V_{PK} - V_{OUT}\right)}$$

Example

$$\frac{dI_{LOAD}}{dt} = \frac{2.5A}{\mu s}$$

This would cause the output current to move from 10A to zero in 4µs as shown by the following equation.

$$C_{OUT} = 12.2 \times \frac{0.88\mu H \times \dfrac{12.2}{1.05} - \dfrac{10}{2.5} \times 1\mu s}{2\left(1.15 - 1.05\right)}$$

C_{OUT} = 379µF

Note that C_{OUT} is much smaller in this example, 379µF compared to 595µF based on a worst-case load release. To

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Applications Information (continued)

meet the two design criteria of minimum 379µF and maximum 9mΩ ESR, select two capacitors rated at 220µF and 15mΩ ESR.

It is recommended that an additional small capacitor be placed in parallel with C_{OUT} in order to filter high frequency switching noise.

Stability Considerations

Unstable operation is possible with adaptive on-time controllers, and usually takes the form of double-pulsing or ESR loop instability.

Double-pulsing occurs due to switching noise seen at the FB input or because the FB ripple voltage is too low. This causes the FB comparator to trigger prematurely after the 250ns minimum off-time has expired. In extreme cases the noise can cause three or more successive on-times. Double-pulsing will result in higher ripple voltage at the output, but in most applications it will not affect operation. This form of instability can usually be avoided by providing the FB pin with a smooth, clean ripple signal that is at least 10mVp-p, which may dictate the need to increase the ESR of the output capacitors. It is also imperative to provide a proper PCB layout as discussed in the Layout Guidelines section.

Another way to eliminate doubling-pulsing is to add a small capacitor across the upper feedback resistor, as shown in Figure 14. This capacitor should be left unpopulated unless it can be confirmed that double-pulsing exists. Adding the C_{TOP} capacitor will couple more ripple into FB to help eliminate the problem. An optional connection on the PCB should be available for this capacitor.
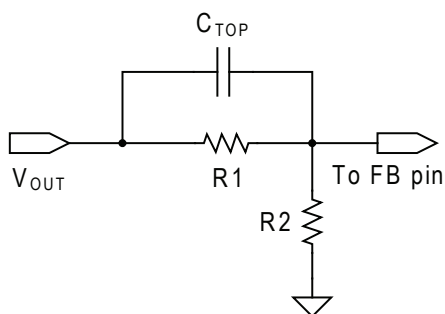

Figure 14 — Capacitor Coupling to FB Pin

ESR loop instability is caused by insufficient ESR. The details of this stability issue are discussed in the ESR Requirements section. The best method for checking stability is to apply a zero-to-full load transient and observe the output voltage ripple envelope for overshoot and ringing. Ringing for more than one cycle after the initial step is an indication that the ESR should be increased.

One simple way to solve this problem is to add trace resistance in the high current output path. A side effect of adding trace resistance is decreased load regulation.

ESR Requirements

A minimum ESR is required for two reasons. One reason is to generate enough output ripple voltage to provide 10mVp-p at the FB pin (after the resistor divider) to avoid double-pulsing.

The second reason is to prevent instability due to insufficient ESR. The on-time control regulates the valley of the output ripple voltage. This ripple voltage is the sum of the two voltages. One is the ripple generated by the ESR, the other is the ripple due to capacitive charging and discharging during the switching cycle. For most applications the minimum ESR ripple voltage is dominated by the output capacitors, typically SP or POSCAP devices. For stability the ESR zero of the output capacitor should be lower than approximately one-third the switching frequency. The formula for minimum ESR is shown by the following equation.

$$ESR_{MIN} = \frac{3}{2 \times \pi \times C_{OUT} \times f_{sw}}$$

Using Ceramic Output Capacitors

When applications use ceramic output capacitors, the ESR is normally too small to meet the previously stated ESR criteria. In these applications it is necessary to add a small virtual ESR network composed of two capacitors and one resistor, as shown in Figure 15.
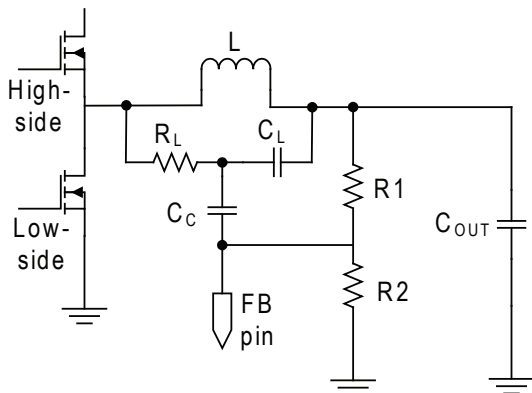
Applications Information (continued)

Figure 15 — Virtual ESR Ramp Current

This network creates a ramp voltage across C_L, analogous to the ramp voltage generated across the ESR of a standard capacitor. This ramp is then capacitively coupled into the FB pin via capacitor C_C.

Dropout Performance

The output voltage adjust range for continuous-conduction operation is limited by the fixed 250ns (typical) minimum off-time of the one-shot. When working with low input voltages, the duty-factor limit must be calculated using worst-case values for on and off times.

The duty-factor limitation is shown by the following equation.

$$DUTY = \frac{T_{ON(MIN)}}{T_{ON(MIN)} + T_{OFF(MAX)}}$$

The inductor resistance and MOSFET on-state voltage drops must be included when performing worst-case dropout duty-factor calculations.

System DC Accuracy (V_{OUT} Controller)

Three factors affect V_{OUT} accuracy: the trip point of the FB error comparator, the ripple voltage variation with line and load, and the external resistor tolerance. The error comparator offset is trimmed so that under static conditions it trips when the feedback pin is 500mV, $\pm$1%.

The on-time pulse from the SC418 in the design example is calculated to give a pseudo-fixed frequency of 250kHz. Some frequency variation with line and load is expected. This variation changes the output ripple voltage. Because adaptive on-time converters regulate to the valley of the output ripple, ½ of the output ripple appears as a DC regulation error. For example, if the output ripple is 50mV with V_{IN} = 6 volts, then the measured DC output will be 25mV above the comparator trip point. If the ripple increases to 80mV with V_{IN} = 25V, then the measured DC output will be 40mV above the comparator trip. The best way to minimize this effect is to minimize the output ripple.

To compensate for valley regulation, it may be desirable to use passive droop. Take the feedback directly from the output side of the inductor and place a small amount of trace resistance between the inductor and output capacitor. This trace resistance should be optimized so that at full load the output droops to near the lower regulation limit. Passive droop minimizes the required output capacitance because the voltage excursions due to load steps are reduced as seen at the load.

The use of 1% feedback resistors contributes up to 1% error. If tighter DC accuracy is required, 0.1% resistors should be used.

The output inductor value may change with current. This will change the output ripple and therefore will have a minor effect on the DC output voltage. The output ESR also affects the output ripple and thus has a minor effect on the DC output voltage.

Switching Frequency Variations

The switching frequency will vary depending on line and load conditions. The line variations are a result of fixed propagation delays in the on-time one-shot, as well as unavoidable delays in the external MOSFET switching. As V_{IN} increases, these factors make the actual DH on-time slightly longer than the ideal on-time. The net effect is that frequency tends to falls slightly with increasing input voltage.

The switching frequency also varies with load current as a result of the power losses in the MOSFETs and the induc-

Applications Information (continued)

tor. For a conventional PWM constant-frequency con-
verter, as load increases the duty cycle also increases
slightly to compensate for IR and switching losses in the
MOSFETs and inductor. A adaptive on-time converter
must also compensate for the same losses by increasing
the effective duty cycle (more time is spent drawing
energy from V_{IN} as losses increase). Because the on-time is
essentially constant for a given V_{OUT}/V_{IN} combination, to
offset the losses the off-time will reduce slightly as load
increases. The net effect is that switching frequency
increases slightly with increasing load.

PCB Layout Guidelines
As with any switch-mode converter, good PCB layout is
essential to achieving high performance. The following
guidelines will provide an optimum PCB layout.

The device layout can be considered in four parts.

- Grounding for PGND and AGND
- Power components
- Low-noise analog circuits
- Bypass capacitors

Grounding for PGND and AGND
- A ground plane layer for PGND is recommended
  to minimize the effects of switching noise, resis-
  tive losses, and to maximize heat removal from
  the power components.
- A separate ground plane or island should be used
  for AGND and all associated components. The
  AGND island should avoid overlapping switching
  signals on other layers (DH/DL/BST/LX).
- Connect PGND and AGND together with a zero
  ohm resistor or copper trace. Make the connec-
  tion near the AGND and PGND pins of the IC.

Power Components
Use short, wide connections between the power
components.

- Input capacitors and high-side MOSFETs
- High-side and Low-side MOSFETs and inductor
  (LX connection). Use wide copper traces to
  provide high current carrying capacity and for
  heat dissipation.
- Inductor and output capacitors.

- All PGND connections — the input capacitors,
  low-side MOSFETs, output capacitors, and the
  PGND pin of the SC418.
  - An inner layer ground plane is recom-
    mended.
  - Each power component requires a short,
    low impedance connection to the PGND
    plane.
  - Place vias to the PGND plane directly near
    the component pins.
- Use short wide traces for the pin connections
  from the SC418 (LX, DH, DL and BST). Do not
  route these traces near the sensitive low-noise
  analog signals (FB, FBL, TON, V_{OUT}).

Low-noise Analog Circuits
Low-noise analog circuits are sensitive circuits that are
referenced to AGND. Due to their high impedance and
sensitivity to noise, it is important that these circuits be
kept away from the switching signals.

- Use a plane or solid area for AGND. Place all
  components connected to AGND above this
  area.
  - Use short direct traces for the AGND con-
    nections to all components.
  - Place vias to the AGND plane directly near
    the component pins.
- Proper routing of the V_{OUT} sense trace is essential
  since it feeds into the FB resistor divider. Noise
  on the FB waveform will cause instability and
  multiple pulsing.
  - Connect the V_{OUT} sense trace directly to
    the output capacitor or a ceramic bypass
    capacitor.
  - Route this trace over to the VOUT pin,
    carefully avoiding all switching signals
    and power components.
  - Route this trace in a quiet layer if possible.
  - Route this trace away from the switch-
    ing traces and components, even if the
    trace is longer. Avoid shorter trace routing
    through the power switching area.
  - If a bypass capacitor is used at the IC side
    of the V_{OUT} sense trace, it should be placed
    near the FB resistor divider.

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Applications Information (continued)

- All components connected to the FB pin must be located near the pin. The FB traces should be kept small and not routed near any noisy switching connections or power components.
- Place the R_{ILIM} resistor near the IC. For an accurate I_{LIM} current sense connection, route the R_{ILIM} trace directly to the drain of the low-side MOSFET (LX). Use an inner routing layer if needed.
- Place the R_{TON} resistor near the TON pin. Route R_{TON} to the TON pin and to AGND using short traces and avoid all switching signals.
- For the LDO components
  - The FBL resistors should be placed near the FBL pin. The area of the FBL traces should be minimized, avoiding all switching connections.

  - The top FBL resistor must route directly to the LDO output capacitor. The LDO load current should not flow through this trace.

Bypass Capacitors

The device requires bypass capacitors for the following pins.

- VDDA pin with respect to AGND. This 0.1µF minimum capacitor must be placed and routed close to the IC pins, on the same layer as the IC.
- VDDP with respect to PGND. This 1µF minimum capacitor must be placed and routed close to the IC pins and on the same layer as the IC.
- BST pin with respect to LX. This 0.1µF minimum capacitor must be placed near the IC, on either side of the PCB. Use short traces for the routing between the capacitor and the IC.
- VLDO pin with respect to AGND.
  - This is the LDO output capacitor.
  - The placement of this capacitor is not critical, however for routing it is important that the top FBL resistor connects directly to this capacitor, and that the LDO load current does not flow through this trace.
  - If VLDO is not used to power the device then a minimum 1µF capacitor referenced to AGND is required.
 - If VLDO is used to power the device then

the VDDA and VDDP capacitors also function as the LDO output capacitor. For VDDA, a minimum 0.1µF capacitor referenced to AGND is required. For VDDP, a minimum 1µF capacitor referenced to PGND is required.

- VIN pin with respect to AGND. This 0.1µF minimum capacitor must be placed and routed close to the IC pins. This capacitor provides noise filtering for the input to the internal LDO.

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Outline Drawing — MLPQ-UT20 3x3

PIN 1
INDICATOR
(LASER MARK)

SEATING
PLANE
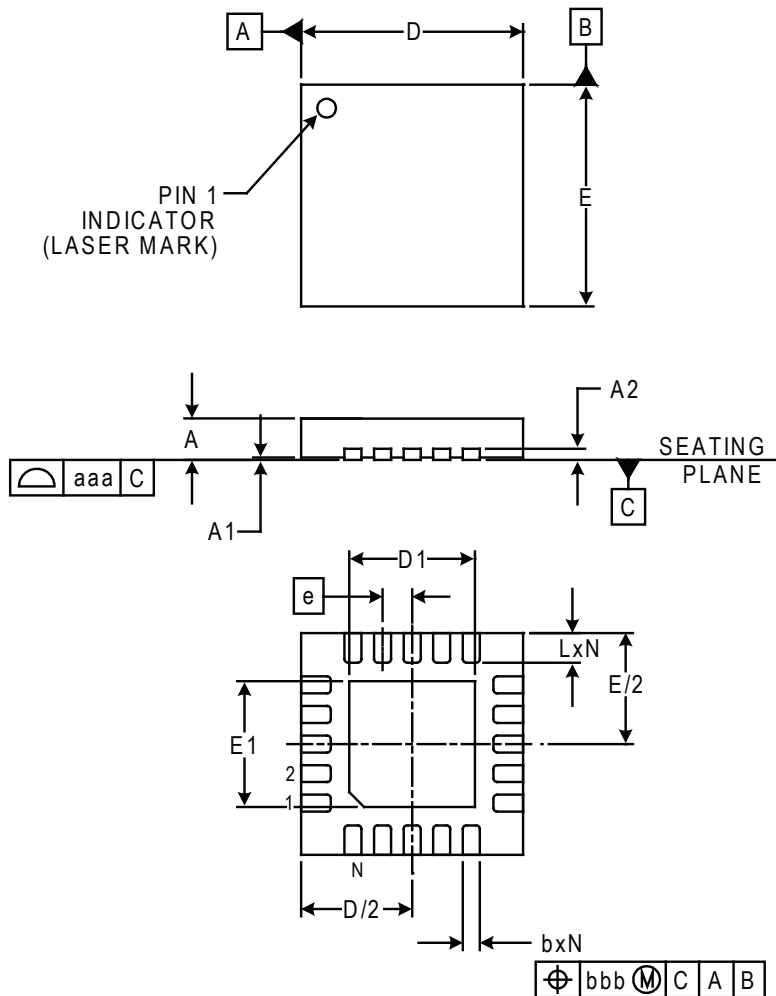
DIMENSIONS						
DIM	INCHES			MILLIMETERS		
	MIN	NOM	MAX	MIN	NOM	MAX
A	.020	-	.024	0.50	-	0.60
A1	.000	-	.002	0.00	-	0.05
A2	(.006)			(0.1524)		
b	.006	.008	.010	0.15	0.20	0.25
D	.114	.118	.122	2.90	3.00	3.10
D1	.061	.067	.071	1.55	1.70	1.80
E	.114	.118	.122	2.90	3.00	3.10
E1	.061	.067	.071	1.55	1.70	1.80
e	.016 BSC			0.40 BSC		
L	.012	.016	.020	0.30	0.40	0.50
N	20			20		
aaa	.003			0.08		
bbb	.004			0.10		

NOTES:

1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).

2. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

3. DAP is 1.90 x 190mm.

Land Pattern — MLPQ-UT20 3x3
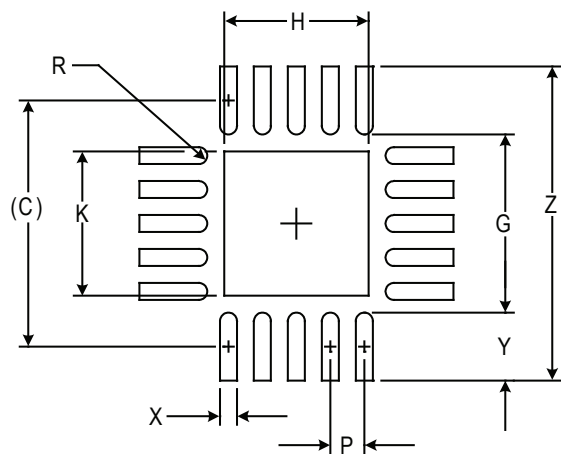
DIMENSIONS		
DIM	INCHES	MILLIMETERS
C	(.114)	(2.90)
G	.083	2.10
H	.067	1.70
K	.067	1.70
P	.016	0.40
R	.004	0.10
X	.008	0.20
Y	.031	0.80
Z	.146	3.70

NOTES:

1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).

2. THIS LAND PATTERN IS FOR REFERENCE PURPOSES ONLY.
   CONSULT YOUR MANUFACTURING GROUP TO ENSURE YOUR
   COMPANY'S MANUFACTURING GUIDELINES ARE MET.

3. THERMAL VIAS IN THE LAND PATTERN OF THE EXPOSED PAD
   SHALL BE CONNECTED TO A SYSTEM GROUND PLANE.
   FAILURE TO DO SO MAY COMPROMISE THE THERMAL AND/OR
   FUNCTIONAL PERFORMANCE OF THE DEVICE.

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